

Supports UEIDaq Framework Data Acquisition Software Library for Windows. Linux and QNX drivers available. Visit our website for more details.

## **General Description:**

True 24-bit resolution makes the DNA/DNR-AI-225 an ideal data acquisition board for a wide range of precision sensors, ranging from thermocouples, to seismic detectors, strain gages, and RTDs (requires external excitation). The DNA-AI-225 is designed for use in UEI's popular cube chassis while the DNR-AI-225 provides identical performance in the new RACKtangle chassis. The boards offer ultra-high resolution (as low as 0.5 µV at 5 Hz), true 24-bit resolution, one converter per channel with simultaneous sampling, and outstanding linearity. The DNA/DNR-AI-225 features sampling rates starting from 5Hz per channel (with 23.5 bits ENOBs) and up to 1 KHz per channel (19 bits ENOBs). Extremely low long-term gain and offset drifts, as well as drift vs. temperature ratio, allows the AI-225 series to be used in a wide range of applications.

The DNA/DNR-AI-225 interfaces directly to thermocouples with a resolution of 0.1° C or better for all thermocouple types across their full temperature range. The layer's unique calibration scheme eliminates initial offset and gain errors across all converters ensuring errors stay within microvolts across the operating range of the product. The software included will perform all required TC linearization and CJC compensation and return data in °C or °F if desired.

#### **Block Diagram:** DC/DC 24-bit Aln24+ A/D Protection /B uf Contro Aln0-້ອ 24-hit Optical Isolation A/DAln0+ SRAM Calibration External Clocks and Triggers Calibration Reference **EEPROM**

# **Pinout Diagram:**



## **Connection Options:**

# CableTerminal PanelDescriptionDNA-CBL-62DNA-STP-62Connects to 62-way terminal panel.DNA-CBL-62DNA-STP-AI-UConnects to the universal analog input terminal panel with built-in high-accuracy CJC temperature sensor, open TC detection circuitry and<br/>additional RC filters on every channel, as well as a precise 5.000V reference and circuitry for the voltage-excited RTDs.

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# **Technical Specifications:**

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Resolution	24 bits	
Number of A/Ds	25	
Sampling rate	5 Hz to 1000 Hz	
Onboard FIFO size	1024 samples	
Input ranges: Bipolar Unipolar	±1.25V (Aln+ & Aln- within -0.25+5V) -0.25 1.25V (Aln- connected to AGND directly or via up to 10 kOhm resistor)	
Input over-/underrange	software detection	
50/60Hz rejection	> 120dB of AC component for rates < 10Hz	
Power supply rejection	> 120dB	
Common mode rejection	120dB typical	
Frontend bandwidth	1250Hz @ -3dB	
Input impedance	100 ΜΩ	
Input bias current	±15 nA	
A/D conversion time	145 msec @ 5-Hz sampling, 1.1 msec @ 500-Hz sampling, 0.57 msec @ 1000-Hz sampling	
System noise*	0.5 μV @ 5Hz, 5.0 μV @ 500 Hz, 7.0 μV @ 1000 Hz	
Effective number of bits*	23.5 bits @ 5 Hz, 20.0 bits @ 500 Hz, 19.0 bits @ 1000 Hz	
Nonlinearity	3 ppm	
Total Harmonic Distortion+N onlinearity+Noise	-110 dB	
Input Protection	2kV ESD, ±15V over/under voltage	
Isolation	350Vrms	
Power consumption	3W - 3.9W	
Operating temp. (tested)	-40°C to +85°C	
Operating humidity	0-95%, non-condensing	
Vibration IEC 60068-2-6 IEC 60068-2-64	5 g, 10-500 Hz, sinusoidal 5 g (rms), 10-500Hz, broadband random	
Shock IEC 60068-2-27	50 g, 3 ms half sine, 18 shocks @ 6 orientations 30 g, 11 ms half sine, 18 shocks @ 6 orientations	
MTBF	520,000 hours	

\* Refer to the test results for detailed information

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# **Test Results**

All tests were conducted under the following conditions: UUT (unit under test) was located inside the temperature-controlled chamber. Except for where noted otherwise, all signal sources were connected outside the test chamber at room temperature.



Peak-peak noise on noisiest channel 100 points RMS noise on noisiest channel

## DNA-AI-225 accuracy in °C when used with DNA-STP-AI-U

Thermocouple Type	Max Error (CJC 25°C), °C	Max Error (CJC 0 to 85°C), °C
В	±1.0	±1.3
C	±0.7	±1.0
E	±0.6	±0.9
J	±0.6	±0.9
K	±0.6	±0.9
Ν	±0.6	±0.9
R	±0.8	±1.1
S	±0.9	±1.2
Т	±0.6	±0.9

Error Includes:

Input measurement error

Input noise (shorted input, P-P noise)
Error due to linearization math

CJC measurement error

Error Does Not Include:

Inherent thermocouple error

• Error caused by thermal gradient on STP